

<b>Notice of References Cited</b>	Application/Control No. 10/771,338		Applicant(s)/Patent Under Reexamination KIM, JONG HEON	
	Examiner KHAI TRAN		Art Unit 2611	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0138030	07-2003	Gavnoudias et al.	375/141
*	C	US-2003/0142726	07-2003	Eltawil et al.	375/146
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